Operating Voltage Range of 4.5 V to 5.5 V

- Outputs Can Drive Up To 10 LSTTL Loads
- Low Power Consumption, 80-μA Max I_{CC}
- Typical t_{pd} = 12 ns
- ±4-mA Output Drive at 5 V
- Low Input Current of 1 μA Max
- Inputs Are TTL-Voltage Compatible

SN54HCT377 J OR W PACKAGE SN74HCT377 DW OR N PACKAGE (TOP VIEW)									
CLKEN 1Q 1D 2D 2Q 3Q 3D 4D 4D 4Q GND	1 2 3 4 5 6 7 8 9 10	20 19 18 17 16 15 14 13 12 11	V _{CC} 8Q 8D 7D 7Q 6Q 6D 5D 5Q CLK						

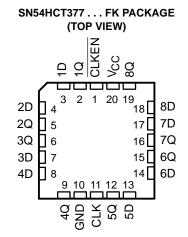
Contain Eight Flip-Flops With Single-Rail Outputs

SN54HCT377, SN74HCT377 OCTAL D-TYPE FLIP-FLOPS

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WITH CLOCK ENABLE

- Clock Enable Latched to Avoid False Clocking
- Applications Include:
 - Buffer/Storage Registers
 - Shift Registers
 - Pattern Generators



description/ordering information

These devices are positive-edge-triggered D-type flip-flops. The 'HCT377 devices are similar to the 'HCT273 devices, but feature a latched clock-enable (CLKEN) input instead of a common clear.

Information at the data (D) inputs meeting the setup time requirements is transferred to the Q outputs on the positive-going edge of the clock (CLK) pulse if CLKEN is low. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When CLK is at either the high or low level, the D input has no effect at the output. These devices are designed to prevent false clocking by transitions at CLKEN.

TA	PACKAG	PACKAGET ORDERABLE PART NUMBER				
	PDIP – N	Tube	SN74HCT377N	SN74HCT377N		
–40°C to 85°C	SOIC - DW	Tube	SN74HCT377DW	HCT377		
	50IC - DW	Tape and reel	SN74HCT377DWR			
	CDIP – J	Tube	SNJ54HCT377J	SNJ54HCT377J		
–55°C to 125°C	CFP – W	Tube	SNJ54HCT377W	SNJ54HCT377W		
	LCCC – FK	Tube	SNJ54HCT377FK	SNJ54HCT377FK		

ORDERING INFORMATION

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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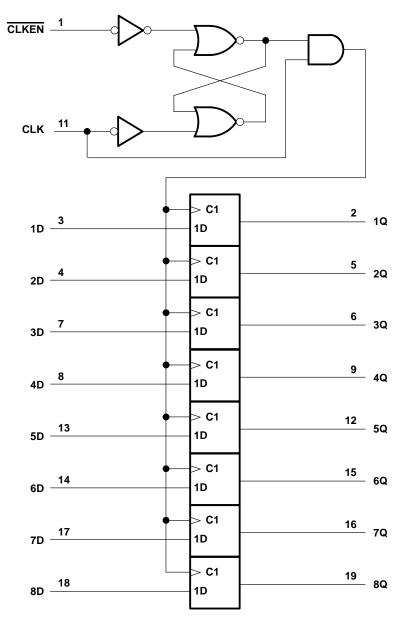


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FUNCTION TABLE

	(each flip-flop)											
II	NPUTS	OUTPUT										
CLKEN	CLK	D	Q									
Н	Х	Х	Q ₀									
L	\uparrow	Н	н									
L	\uparrow	L	L									
х	L	Х	Q ₀									

logic diagram (positive logic)





SN54HCT377, SN74HCT377 OCTAL D-TYPE FLIP-FLOPS WITH CLOCK ENABLE

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{CC}) (see Note 1)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ_{JA} (see Note 2): DW package	58°C/W
N package	69°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

			SN	54HCT3	77	SN	74HCT3	77	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	\$ 5.5	4.5	5	5.5	V
VIH	High-level input voltage	V_{CC} = 4.5 V to 5.5 V	2	ľ.	1/2	2			V
VIL	Low-level input voltage	V_{CC} = 4.5 V to 5.5 V		P.	0.8			0.8	V
VI	Input voltage		0	1	VCC	0		VCC	V
Vo	Output voltage		0	50	VCC	0		VCC	V
tt	Input transition (rise and fall) times		0		500			500	ns
TA	Operating free-air temperature		-55		125	-40		85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER TEST CONDITIONS			Т	A = 25°C	;	SN54H	CT377	SN74H	CT377	UNIT
PARAMETER	TEST CC	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
∨он	VI = VIH or VIL	I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		V
VОН	VI = VIH OL VIL	$I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.30		3.7	N	3.84		v
Ve	$\lambda = \lambda = 0$	I _{OL} = 20 μA	4.5 V		0.001	0.1		0.1		0.1	V
V _{OL} V _I = V _{IH} or V _{IL}		I _{OL} = 4 mA	4.5 V		0.17	0.26		0.4		0.33	v
lj	$V_I = V_{CC} \text{ or } 0$		5.5 V		±0.1	±100	1	±1000		±1000	nA
ICC	$V_I = V_{CC} \text{ or } 0,$	IO = 0	5.5 V			8	DN	160		80	μA
∆ICC‡	One input at 0.5 V Other inputs at GN		5.5 V		1.4	2.4	10yd	3		2.9	mA
Ci						10		10*		10	pF

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

[‡]This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or V_{CC}.



timing requirements over recommended operating free-air temperature range (unless otherwise noted)

			N	T _A = 2	25°C	SN54H	CT377	SN74HCT377			
			Vcc	MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
f., .	Clock frequency		4.5 V		25		17		20	MHz	
fclock	Clock nequency		5.5 V		30		19		22		
+	Pulse duration	CLK high or low	4.5 V	20		30		25		200	
tw	ruise duration		5.5 V	18		28	ĬE,	23		ns	
		Data	4.5 V	12		18	IE I	15			
	Setup time before CLK1	Dala	5.5 V	10		17	Q	14		ns	
t _{su}	Setup time before CLK		4.5 V	12		18		15			
		CLKEN high or low	5.5 V	10		17		14			
		Data	4.5 V	3		\$ 3		3			
+ .	Hold time data after CLK↑	Dala	5.5 V	3		3		3		ns	
^t h			4.5 V	5		5		5			
		CLKEN inactive or active	5.5 V	5		5		5			

switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

	55.011	то (оитрит)			SN	54HCT3	77		
PARAMETER	FROM (INPUT)		Vcc	T _A = 25°C			MIN MA	МАХ	UNIT
	(MIN	TYP	MAX		IVIAA	
fmax			4.5 V	25	31	11.	17		MHz
			5.5 V	30	37	PE	19		
. .	0.14	A. 101	4.5 V		15	30		45	ns
^t pd	CLK	Any	5.5 V		12	S 28		40	
+		Apv	4.5 V		8	15		22	ns
tt		Any	5.5 V		6	14		21	

switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

	55.011	TO (OUTPUT)	vcc						
PARAMETER	FROM (INPUT)			T _A = 25°C			MIN	МАХ	UNIT
	(MIN	TYP	MAX	IVIIIN		
fmax			4.5 V	25	31		20		MHz
			5.5 V	30	37		22		
.	0.14	Anv	4.5 V		15	30		38	ns
^t pd	CLK	Any	5.5 V		12	28		35	
+.			4.5 V		8	15		19	
tt		Any	5.5 V		6	14		17	ns

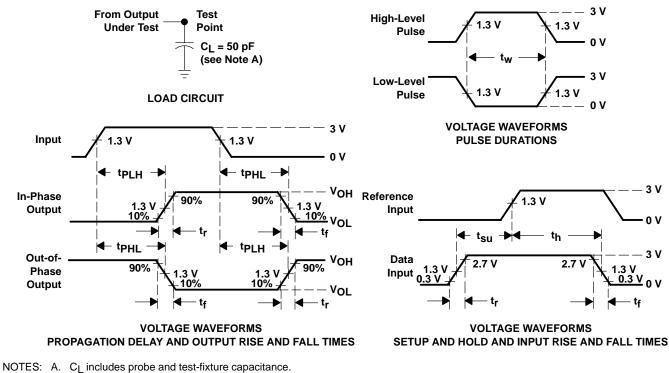
operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
Cpd	Power dissipation capacitance	No load	30	pF



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PARAMETER MEASUREMENT INFORMATION



- - B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f = 6 ns, t_f = 6 ns.
 - C. The outputs are measured one at a time with one input transition per measurement.
 - D. For clock inputs, $f_{\mbox{max}}$ is measured when the input duty cycle is 50%.
 - E. tpl H and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms





10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
SN74HCT377DW	(1) ACTIVE	SOIC	DW	20	25	(2) Green (RoHS & no Sb/Br)	(6) CU NIPDAU	(3) Level-1-260C-UNLIM	-40 to 85	(4/5) HCT377	Samples
SN74HCT377DWG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT377	Samples
SN74HCT377DWR	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT377	Samples
SN74HCT377DWRE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT377	Samples
SN74HCT377N	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN74HCT377N	Samples
SN74HCT377NE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN74HCT377N	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



PACKAGE OPTION ADDENDUM

10-Jun-2014

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION

REEL DIMENSIONS

TEXAS INSTRUMENTS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HCT377DWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1

TEXAS INSTRUMENTS

www.ti.com

PACKAGE MATERIALS INFORMATION

14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HCT377DWR	SOIC	DW	20	2000	367.0	367.0	45.0

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

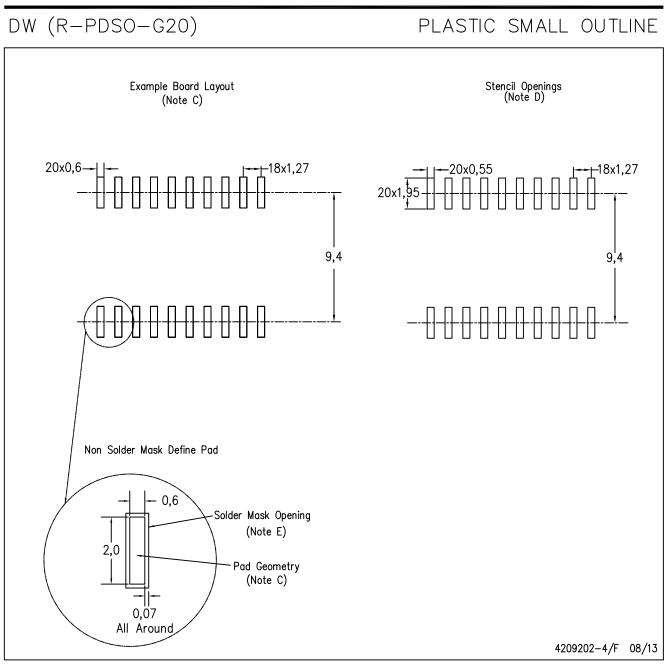
B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



LAND PATTERN DATA



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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